

III B.Tech II Semester Supplementary Examinations, Apr/May 2008
VLSI DESIGN

(Common to Electronics & Communication Engineering and Electronics & Telematics)

Time: 3 hours

Max Marks: 80

Answer any FIVE Questions
All Questions carry equal marks

1. (a) Derive an equation for I_{DS} of an n-channel Enhancement MOSFET operating in linear region.
(b) A PMOS transistor is operating in saturation region with the following parameters. $V_{GS} = -5V$; $V_{tp} = -1.2V$; $W/L = 95$; $\mu_n C_{ox} = 95 \mu A/V^2$
Find Trans conductance of the device. [8+8]
2. With neat sketches explain how Diodes and Resistors are fabricated in Bipolar process. [16]
3. Design a stick diagram for two input n-MOS NAND and NOR gates. [16]
4. Design a layout diagram for nMOS inverter. [16]
5. Calculate ON resistance from V_{DD} to GND for the given inverter circuit shown in Figure 5, If n-channel sheet resistance is $3 \times 10^4 \Omega$ per square. [16]

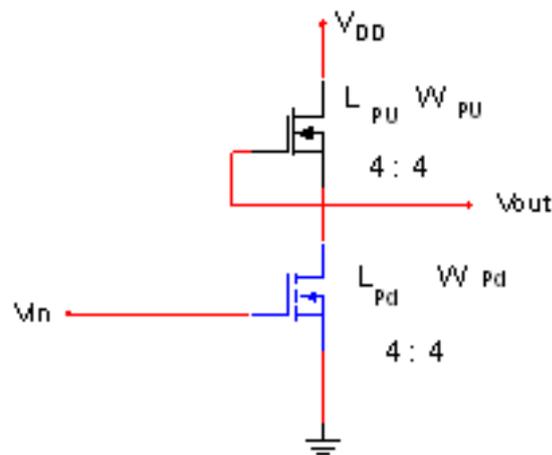


Figure 5

6. Clearly discuss about the following FPGA Technology
 - (a) Anti fuse Technology.
 - (b) Static RAM Technology. [8+8]
7. Explain the following process in the ASIC design flow.
 - (a) Functional gate level verification.

Code No: RR320405

Set No. 1

- (b) Static timing analysis. [8+8]
8. (a) Mention the properties of the twin oxide.
- (b) Clearly explain about ION implantation step in IC fabrication. [6+10]

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1. (a) With neat sketches explain the formation of the inversion layer in P-channel Enhancement MOSFET.
(b) An NMOS Transistor is operated in the triode region with the following parameters $V_{GS} = 4V$; $V_{tn} = 1V$; $V_{DS} = 2V$; $W/L = 100$; $\mu_n C_{ox} = 90 \mu A/V^2$
Find its drain current and drain source resistance. [8+8]
2. (a) With neat sketches explain how resistors and capacitors are fabricated in p-well process.
(b) With neat sketches explain how resistors and capacitors are fabricated in n-well process. [8+8]
3. Design a stick diagram for the CMOS logic shown below $Y = \overline{(AB + CD)}$ [16]
4. Design a layout diagram for the NMOS logic shown below $Y = \overline{(A + B).C}$ [16]
5. Explain clearly about different parastic capacitances of an nMOS transistor. [16]
6. Implement Full-adder circuit using PAL. [16]
7. What is need for RTL simulation? Clearly explain RTL simulation flow in the ASIC design flow and also mention few leading simulation tools. [16]
8. With neat sketches explain the ION- lithography process. [16]

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Find its drain current and drain source resistance. [8+8]
2. With neat sketches explain CMOS fabrication using Twin - Tub process. [16]
3. Design a stick diagram for the PMOS logic shown below $Y = \overline{(AB + CD)}$ [16]
4. Design a layout diagram for two input nMOS NAND gate. [16]
5. Two nMOS inverters are cascaded to drive a capacitive load $C_L = 16C_g$ as shown in Figure 5. Calculate the pair delay V_{in} to V_{out} in terms of τ for the given data.

Inverter -A

$$L_{P,U} = 16\lambda, W_{P,U} = 2\lambda, L_{P,d} = 2\lambda, W_{P,d} = 2\lambda$$

Inverter -B

$$L_{P,U} = 2\lambda, W_{P,U} = 2\lambda, L_{P,d} = 2\lambda, W_{P,d} = 8\lambda \quad [16]$$

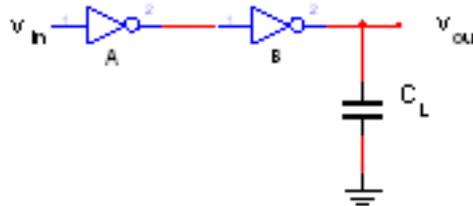


Figure 5

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 - (a) Anti fuse Technology.
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7. Explain the following process in the ASIC design flow.
 - (a) Functional gate level verification.
 - (b) Static timing analysis. [8+8]
8. (a) Mention the properties of the twin oxide.

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(b) Clearly explain about ION implantation step in IC fabrication. [6+10]

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 Find Trans conductance of the device. [8+8]
2. (a) Compare between CMOS and bipolar technologies.
 (b) With neat sketches explain nMOS fabrication process. [8+8]
3. Design a stick diagram for the CMOS logic shown below $Y = \overline{(A + B).C}$ [16]
4. Design a layout diagram for two input CMOS NOR gate. [16]
5. Calculate ON resistance from V_{DD} to GND for the given inverter circuit shown in Figure 5, If n-channel sheet resistance is $3 \times 10^4 \Omega$ per square. [16]

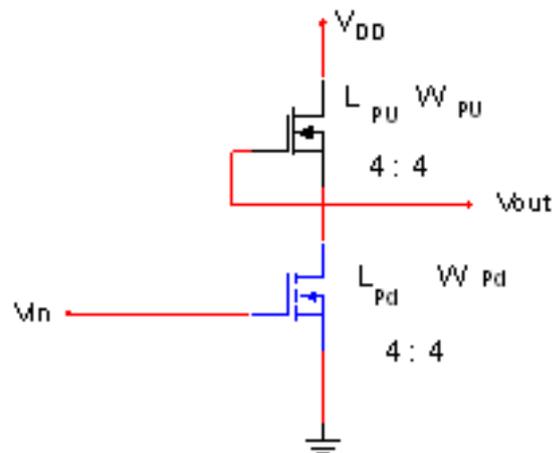


Figure 5

6. With neat sketch clearly explain the architecture of a PLA. [16]
7. (a) What is the goal of VHDL synthesis step in design flow?
 (b) Explain how register transfer level description provides optimized synthesis netlist. [8+8]
8. With neat sketches explain the ION- lithography process. [16]
